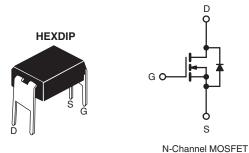


Vishay Siliconix

Power MOSFET

| PRODUCT SUMMARY | | | | |
|----------------------------|------------------------|------|--|--|
| V _{DS} (V) | 100 | | | |
| $R_{DS(on)}(\Omega)$ | V _{GS} = 10 V | 0.27 | | |
| Q _g (Max.) (nC) | 16 | | | |
| Q _{gs} (nC) | 4.4 | | | |
| Q _{gd} (nC) | 7.7 | | | |
| Configuration | Single | | | |



FEATURES

- Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- 175 °C Operating Temperature
- Fast Switching
- · Ease of Paralleling
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

| ORDERING INFORMATION | |
|----------------------|-------------|
| Package | HEXDIP |
| Lead (Pb)-free | IRFD123PbF |
| Leau (FD)-liee | SiHFD123-E3 |
| SnPb | IRFD123 |
| SILL | SiHFD123 |

| ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted | | | | | | |
|--|-------------------------|-------------------------|-----------------------------------|------------------|------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V _{DS} | 100 | V | |
| Gate-Source Voltage | | | V_{GS} | ± 20 | V | |
| Continuous Drain Current | V _{GS} at 10 V | T _C = 25 °C | I _D | 1.3 | А | |
| | | T _C = 100 °C | | 0.94 | | |
| Pulsed Drain Current ^a | | | I _{DM} | 10 | | |
| Linear Derating Factor | | | | 0.0083 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 100 | mJ | |
| Repetitive Avalanche Current ^a | | | I _{AR} | 1.3 | Α | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 0.13 | mJ | |
| Maximum Power Dissipation | T _C = 25 °C | | P_{D} | 1.3 | W | |
| Peak Diode Recovery dV/dt ^c | | | dV/dt | 5.5 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | - 55 to + 175 | - °C | |
| Soldering Recommendations (Peak Temperature) | for 10 s | | | 300 ^d | | |

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 22 mH, R_G = 25 Ω , I_{AS} = 2.6 A (see fig. 12).
- c. $I_{SD} \le 9.2$ A, $dI/dt \le 110$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFD123, SiHFD123

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| THERMAL RESISTANCE RATINGS | | | | | |
|-----------------------------|-------------------|------|------|------|--|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT | |
| Maximum Junction-to-Ambient | R _{thJA} | - | 120 | °C/W | |

| PARAMETER | SYMBOL | TES | MIN. | TYP. | MAX. | UNIT | |
|---|-----------------------|--|--|------|------|------------------|------|
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} | 100 | - | - | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Referen | Reference to 25 °C, I _D = 1 mA | | 0.13 | - | V/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} : | $V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$ | | - | 4.0 | V |
| Gate-Source Leakage | I _{GSS} | V _{GS} = ± 20 V | | - | - | ± 100 | nA |
| Zone Onto Valle on Busin Oursell | | V _{DS} = 100 V, V _{GS} = 0 V | | - | - | 25 | μΑ |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 80 V | V _{DS} = 80 V, V _{GS} = 0 V, T _J = 150 °C | | - | 250 | |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 0.78 A ^b | - | - | 0.27 | Ω |
| Forward Transconductance | 9 _{fs} | V _{DS} = 50 V, I _D = 0.78 A ^b | | 0.80 | - | - | S |
| Dynamic | | | | | | | |
| Input Capacitance | C _{iss} | $V_{GS} = 0 \text{ V}$ $V_{DS} = 25 \text{ V}$ $f = 1.0 \text{ MHz, see fig. 5}$ | | - | 360 | - | pF |
| Output Capacitance | C _{oss} | | | - | 150 | - | |
| Reverse Transfer Capacitance | C _{rss} | | | - | 34 | - | |
| Total Gate Charge | Qg | V _{GS} = 10 V | I _D = 9.2 A, V _{DS} = 80 V see fig. 6 and 13 ^b | - | - | 16 | nC |
| Gate-Source Charge | Q _{gs} | | | - | - | 4.4 | |
| Gate-Drain Charge | Q_{gd} | | goo ngi o ana 10 | - | - | 7.7 | |
| Turn-On Delay Time | t _{d(on)} | V_{DD} = 50 V, I_{D} = 9.2 A R_{G} = 18 Ω , R_{D} = 5.2 Ω , see fig. 10 ^b | | - | 6.8 | - | - ns |
| Rise Time | t _r | | | - | 27 | - | |
| Turn-Off Delay Time | t _{d(off)} | | | - | 18 | - | |
| Fall Time | t _f | | | - | 17 | - | |
| Internal Drain Inductance | L_D | Between lead, 6 mm (0.25") from package and center of die contact | | - | 4.0 | ı | nH |
| Internal Source Inductance | L _S | | | - | 6.0 | - | "" |
| Drain-Source Body Diode Characteristic | s | | | | | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 1.3 | A |
| Pulsed Diode Forward Current ^a | I _{SM} | | | - | - | 10 | A |
| Body Diode Voltage | V _{SD} | $T_J = 25 ^{\circ}\text{C}, I_S = 1.3 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$ | | - | - | 2.5 | V |
| Body Diode Reverse Recovery Time | t _{rr} | $T_J = 25 ^{\circ}\text{C}, I_F = 9.2 \text{A}, dI/dt = 100 \text{A/}\mu\text{s}^b$ | | - | 130 | 260 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | - | 0.65 | 1.3 | μC |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D) | | | | L _D) | |

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

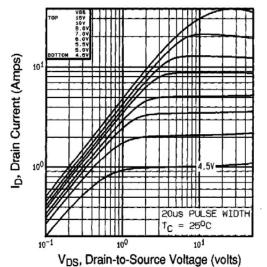


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

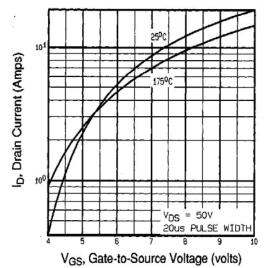


Fig. 3 - Typical Transfer Characteristics

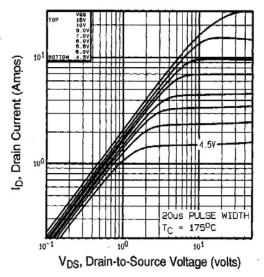


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

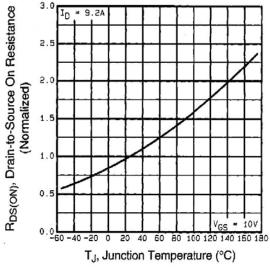


Fig. 4 - Normalized On-Resistance vs. Temperature

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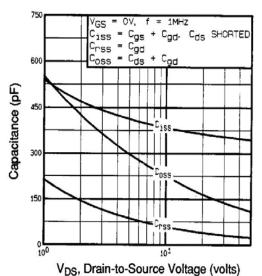


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

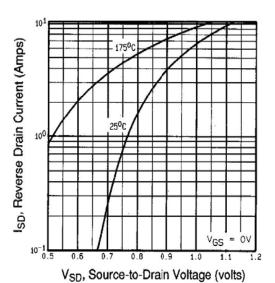


Fig. 7 - Typical Source-Drain Diode Forward Voltage

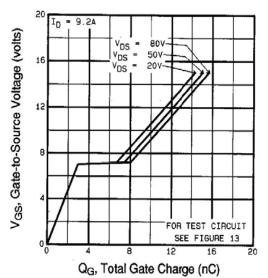


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

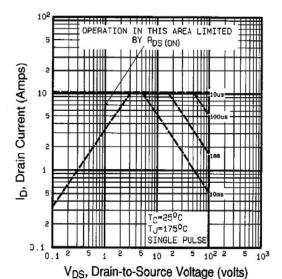


Fig. 8 - Maximum Safe Operating Area





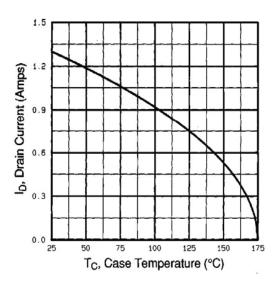


Fig. 9 - Maximum Drain Current vs. Case Temperature

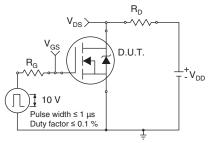


Fig. 10a - Switching Time Test Circuit

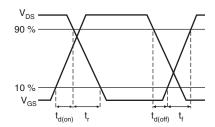


Fig. 10b - Switching Time Waveforms

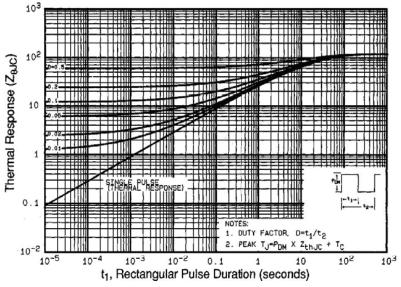


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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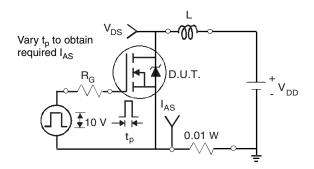


Fig. 12a - Unclamped Inductive Test Circuit

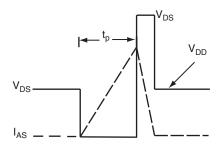


Fig. 12b - Unclamped Inductive Waveforms

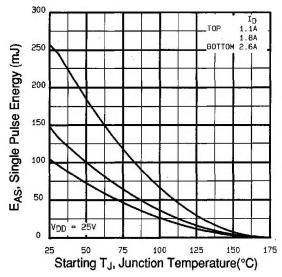


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

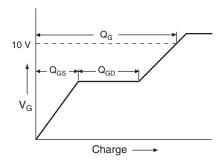


Fig. 13a - Basic Gate Charge Waveform

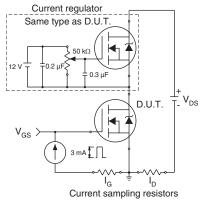
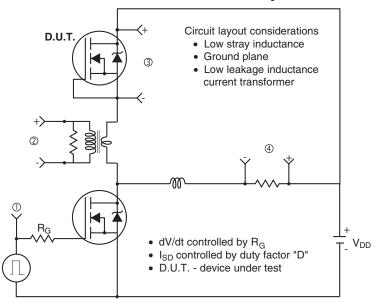
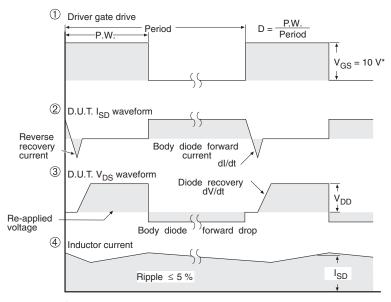


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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